



Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 1075.1253	APPLICATION NO. 10/785,118
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		FIRST NAMED INVENTOR Osamu KIMURA, et al.	
		FILING DATE February 25, 2004	GROUP ART UNIT 2186

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
(A)	AA	5,937,174	8/10/1999	Weber	395	309	6/28/1996
(A)	AB	2003/015899	8/21/2003	Hauck et al.	711	113	2/21/2002
(A)	AC	2004/0117579	6/17/2004	Wu et al.	711	170	12/13/2002
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

**TRANSLATION
YES NO**

(A)	AM	Copy of European Search Report for EP Patent Application No. 04257279.2, dated July 6, 2005.		
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EXAMINER	DATE CONSIDERED
	3/7/06

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTORNEY DOCKET NO.
1075.1253

APPLICATION NO.

FIRST NAMED INVENTOR

Osamu KIMURA, et al.

FILING DATE

February 25, 2004

GROUP ART UNIT

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
<i>AB</i>	AA	5,819,054	10/6/98	Ninomiya, et al.	395	308	3/17/97
<i>AB</i>	AB	6,012,119	1/4/00	Ninomiya, et al.	710	128	1/26/98
<i>AB</i>	AC	6,578,100	6/10/03	Ninomiya, et al.	710	305	11/15/99
<i>AB</i>	AD	6,581,128	6/17/03	Ninomiya, et al.	710	305	8/22/01

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES	NO
<i>AB</i>	AE	HEI 7-160432	6/23/95	Japan			Abstract and translation of [0001] to [0009] in Detailed Description of the Invention	
<i>AB</i>	AF	HEI 5-189314	7/30/93	Japan			Abstract and translation of [0001] to [0019] in Detailed Description of the Invention	
	AG	HEI 7-20094	1/24/95	Japan				<input checked="" type="checkbox"/>

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AH	
	AI	
	AJ	

EXAMINER

DATE CONSIDERED

3/7/01

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.